

HUF76145S3S-VB Datasheet

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^{a, e}	Q_g (Typ)
30	0.0024 at $V_{GS} = 10$ V	98	82 nC
	0.0027 at $V_{GS} = 4.5$ V	98	

FEATURES

- Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU


RoHS
 COMPLIANT

APPLICATIONS

- OR-ing
- Server
- DC/DC



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 175^\circ\text{C}$)	$T_C = 25^\circ\text{C}$	I_D	98 ^{a, e}	A
	$T_C = 70^\circ\text{C}$		98 ^e	
	$T_A = 25^\circ\text{C}$		28.8 ^{b, c}	
	$T_A = 70^\circ\text{C}$		27 ^{b, c}	
Pulsed Drain Current		I_{DM}	300	
Avalanche Current Pulse		I_{AS}	36	
Single Pulse Avalanche Energy		E_{AS}	64.8	V
Continuous Source-Drain Diode Current	$T_C = 25^\circ\text{C}$	I_S	90 ^{a, e}	A
	$T_A = 25^\circ\text{C}$		3.13 ^{b, c}	
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	250 ^a	W
	$T_C = 70^\circ\text{C}$		175	
	$T_A = 25^\circ\text{C}$		3.75 ^{b, c}	
	$T_A = 70^\circ\text{C}$		2.63 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 175	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typ.	Max.	Unit
Maximum Junction-to-Ambient ^{b, d}	$t \leq 10$ sec	R_{thJA}	32	40	$^\circ\text{C/W}$
Maximum Junction-to-Case	Steady State	R_{thJC}	0.5	0.6	

Notes:

 a. Based on $T_C = 25^\circ\text{C}$.

b. Surface mounted on 1" x 1" FR4 board.

 c. $t = 10$ sec.

 d. Maximum under steady state conditions is 90°C/W .

e. Calculated based on maximum junction temperature. Package limitation current is 90 A.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		35		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			- 7.5		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.5		2.5	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μA
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	90			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 28.8 A		0.0024		Ω
		V _{GS} = 4.5 V, I _D = 27 A		0.0027		
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 28.8 A		160		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		12065		pF
Output Capacitance	C _{oss}			1725		
Reverse Transfer Capacitance	C _{rss}			970		
Total Gate Charge	Q _g	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 28.8 A		171	257	nC
		V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 28.8 A		81.5	123	
Gate-Source Charge	Q _{gs}			34		
Gate-Drain Charge	Q _{gd}			29		
Gate Resistance	R _g	f = 1 MHz		1.4	2.1	Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 0.625 Ω I _D ≅ 24 A, V _{GEN} = 10 V, R _g = 1 Ω		18	27	ns
Rise Time	t _r			11	17	
Turn-Off Delay Time	t _{d(off)}			70	105	
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 0.67 Ω I _D ≅ 22.5 A, V _{GEN} = 4.5 V, R _g = 1 Ω		55	83	
Rise Time	t _r			180	270	
Turn-Off Delay Time	t _{d(off)}			55	83	
Fall Time	t _f			12	18	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			90	A
Pulse Diode Forward Current ^a	I _{SM}				90	
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		52	78	ns
Body Diode Reverse Recovery Charge	Q _{rr}			70.2	105	nC
Reverse Recovery Fall Time	t _a			27		ns
Reverse Recovery Rise Time	t _b			25		

Notes:

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

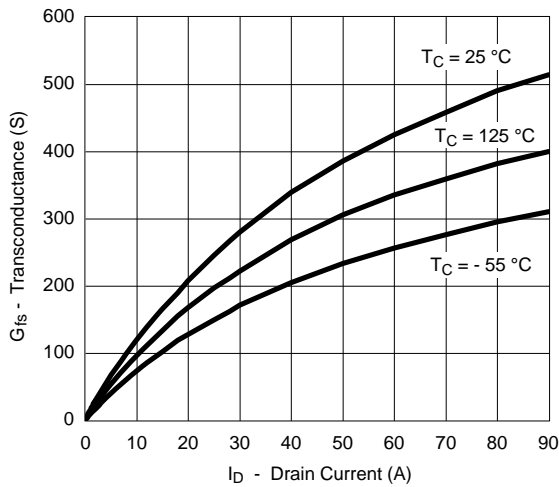
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Output Characteristics



Transfer Characteristics



Transconductance



$R_{DS(on)}$ vs. Drain Current



Capacitance



Gate Charge

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



On-Resistance vs. Junction Temperature



Forward Diode Voltage vs. Temperature



$R_{DS(on)}$ vs. V_{GS} vs. Temperature



Threshold Voltage



Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



*The power dissipation P_D is based on $T_{J(max)} = 175\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



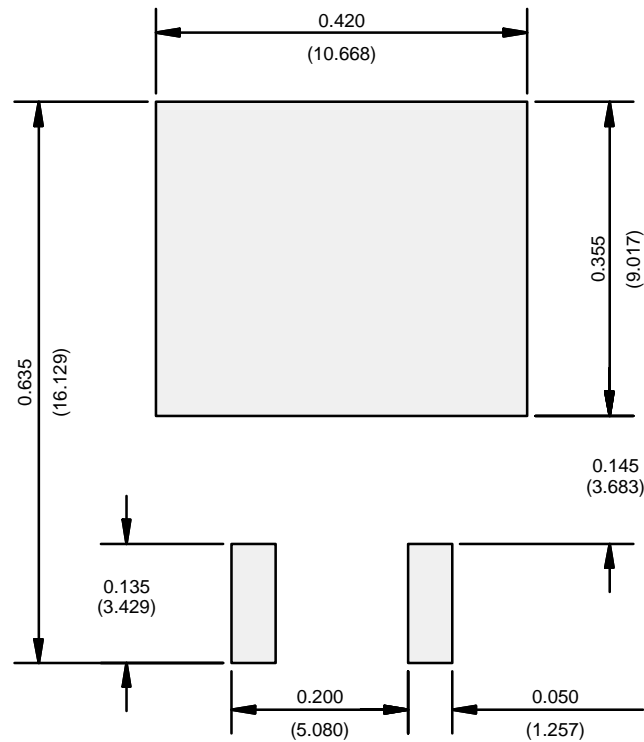
Technical drawing of a lead tip assembly, showing multiple views and annotations:

- Main View (Top Left):** Shows the lead tip assembly with dimensions $L1$, D , H , E , and $L2$. It includes feature callouts 1, 2, 3, 4, and 5. Datum A is indicated. Section lines A-A and B-B are shown. Tolerances are specified: $\phi 0.010 \text{ M A B}$ and $\text{Plating } \pm 0.004 \text{ M B}$. Material callouts include $2 \times b2$, $2 \times b$, and $2 \times \text{Lead}$.
- Detail A (Top Right):** A magnified view of the lead tip, showing dimensions A , $c2$, and c . It includes a section line A-A and a tolerance of $\pm 0.004 \text{ M B}$.
- Section B - B and C - C (Bottom Left):** A cross-sectional view showing the lead tip, plating, and base metal. Dimensions include $b1$, $b3$, $c1$, c , and $(b, b2)$. It includes a section line B-B and a tolerance of $\pm 0.004 \text{ M B}$.
- View A - A (Bottom Right):** A side view of the lead tip, showing dimensions E , $D1$, and $E1$. It includes a section line A-A and a tolerance of $\pm 0.004 \text{ M B}$.
- Detail A (Bottom Right):** A magnified view of the lead tip, showing dimensions $L4$ and $A1$. It includes a section line A-A and a tolerance of $\pm 0.004 \text{ M B}$.
- Lead Tip (Bottom Left):** A small detail view of the lead tip, showing a dimension of $2 \times \text{Lead}$.
- Seating Plane (Top Right):** A detail view of the seating plane, showing dimensions $L3$ and $L4$. It includes a section line A-A and a tolerance of $\pm 0.004 \text{ M B}$.
- Annotations:**
 - (Datum A):** Indicated by a triangle with the letter A.
 - Lead tip:** Indicated by an arrow pointing to the lead tip.
 - Seating plane:** Indicated by an arrow pointing to the seating plane.
 - Detail A:** Indicated by an arrow pointing to the magnified view of the lead tip.
 - View A - A:** Indicated by an arrow pointing to the side view of the lead tip.
 - Section B - B and C - C:** Indicated by an arrow pointing to the cross-sectional view.
 - Plating:** Indicated by an arrow pointing to the plating layer.
 - Base metal:** Indicated by an arrow pointing to the base metal.
 - Scale:** Scale: none.
 - Scale 8:1:** Scale 8:1.
 - Rotated 90° CW:** Rotated 90° CW.

	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
e	2.54 BSC		0.100 BSC	
H	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	-	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010 BSC	
L4	4.78	5.28	0.188	0.208

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimensions are shown in millimeters (inches).
3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
5. Dimension b1 and c1 apply to base metal only.
6. Datum A and B to be determined at datum plane H.
7. Outline conforms to JEDEC outline to TO-263AB.

RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads
Dimensions in Inches/(mm)

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